



17. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

FCC ID: A3LSMJ327R4		HAC (RF EMISSIONS) TEST REPORT		Approved by: Quality Manager
Filename: 1M1702170067-11-R1.A3L	Test Dates: 2/20/2017 - 3/8/2017	DUT Type: Portable Handset	Page 66 of 68	

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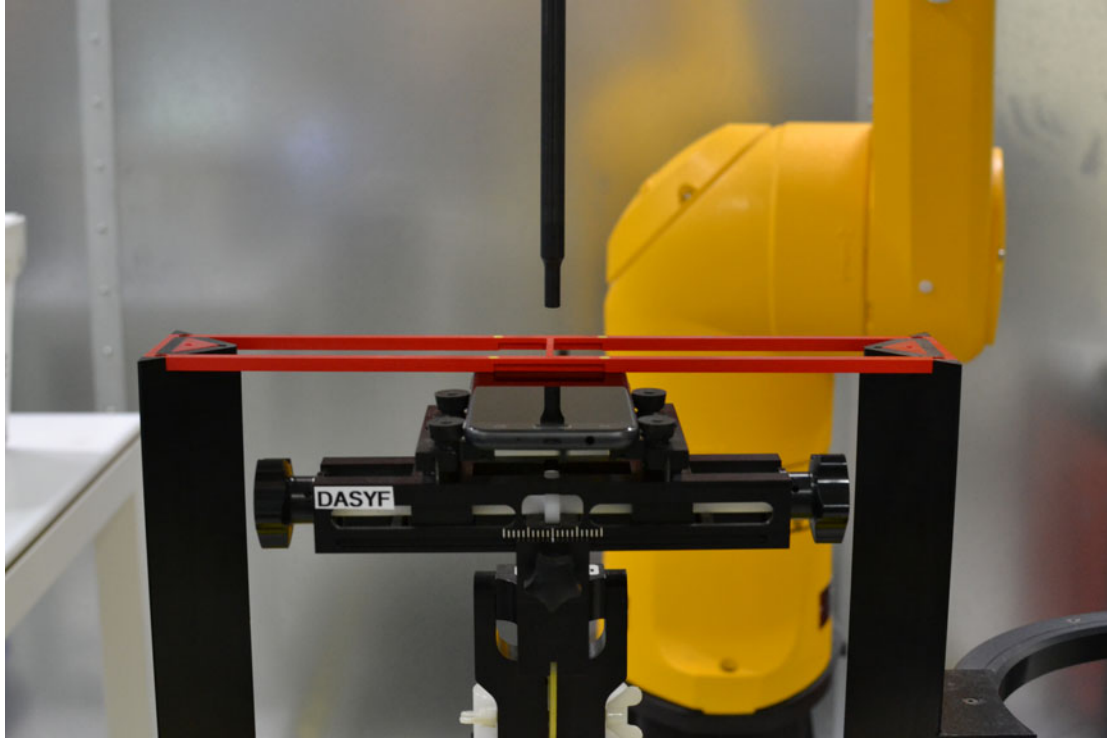


Figure 17-1
Ear Reference Point HAC Phantom Alignment

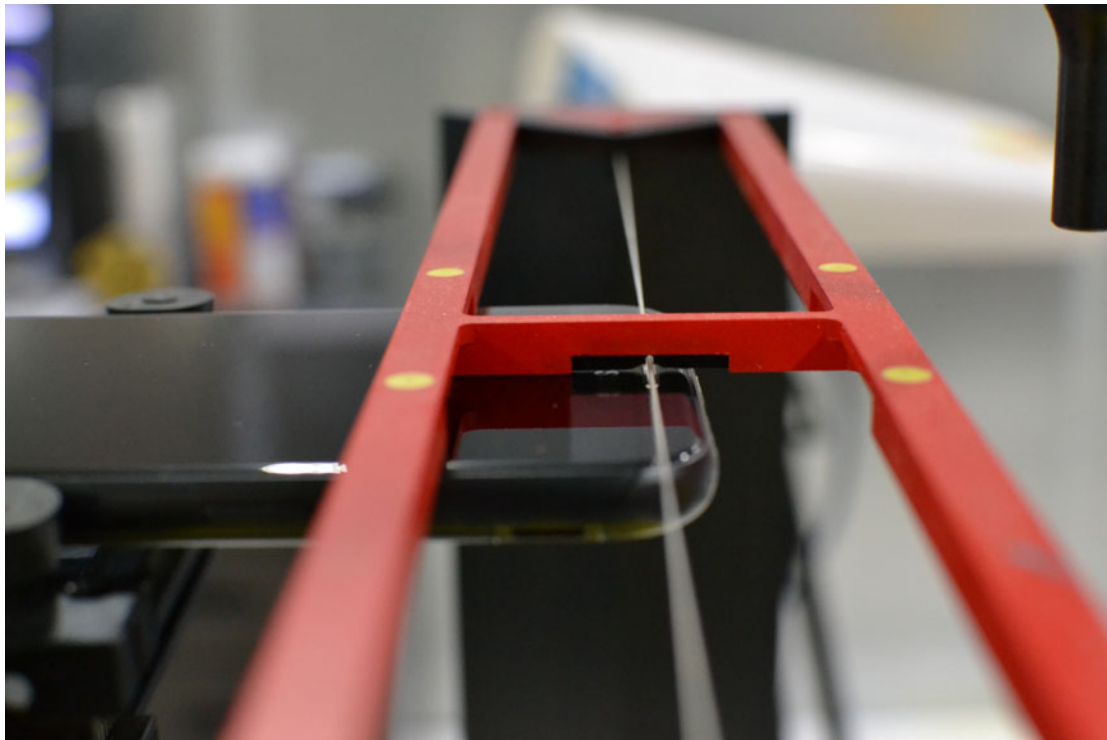




Figure 17-2
HAC Phantom Plane Alignment

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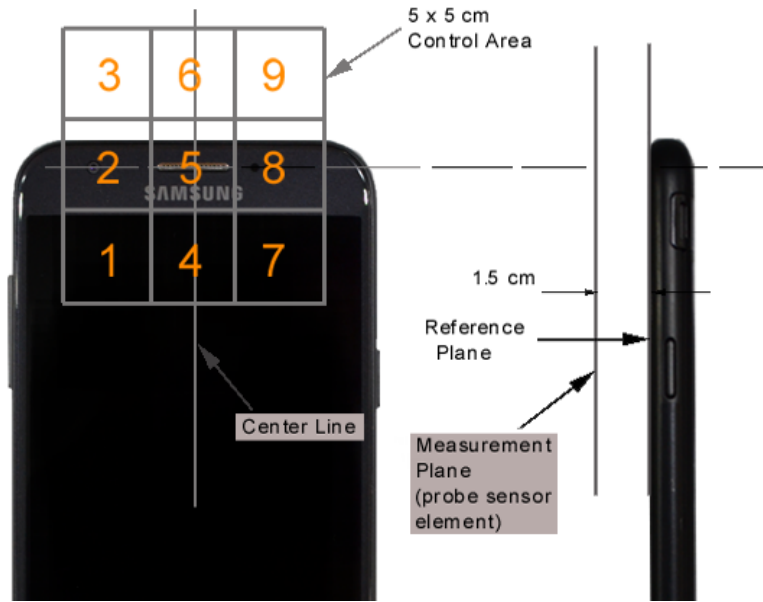




Figure 17-3 5x5 Scan grid above WD



Figure 17-4 E-Field WD Scan overlay

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